Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	٢	
09/978,214	YAMAKAWA ET AL.		
Examiner	Art Unit		
David Y. Jung	2134		

SEARCHED				
Class	Subclass	Date	Examiner	
726	11-14	9/15/2005	נם	
726	30	9/15/2005	DJ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
726	11	9/15/2005	DJ	
726	14	9/15/2005	DJ	
726	30	9/15/2005	מ	

SEARCH N (INCLUDING SEAR))
	DATE	EXMR
West, NPL, Internet	9/15/2005	רם
look at previously searched subclasses of US Patents	9/15/2005	DJ